

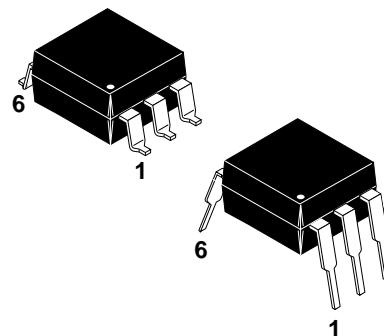
## DESCRIPTION

The CNW82, CNW83, CNW84 and CNW85 optocouplers consist of a GaAs infrared emitting diode which is optically coupled to an NPN phototransistor.

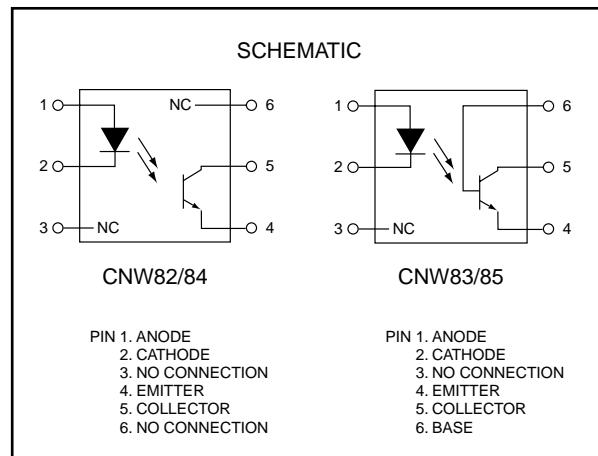
The CNW82 and CNW84 do not have the base pin connected for improved noise immunity.

## FEATURES

- Wide body DIL encapsulation, with a pin distance of 10.16 mm.
- Minimum creepage distance 10 mm.
- High current transfer ratio and Low Saturation Voltage, making the device suitable for use with TTL integrated circuits.
- High degree of AC and DC insulation (5900 V (RMS) and 8340 V (DC)).
- Minimum 2 mm isolation thickness between emitter and detector. (CNW84/85 only).
- An external clearance of 9.6 mm minimum and an external creepage distance of 10 mm minimum.
- Collector-Emitter Breakdown Voltage: 50 V (CNW82/83 only).
- Collector-Emitter Breakdown Voltage: 80 V (CNW84/85 only).
- UL recognized (File # E90700)



**CNW82  
CNW83  
CNW84  
CNW85**



## ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Units
<b>EMITTER</b>			
Forward Current - Continuous	$I_F$	100	mA
Forward Current - Peak ( $PW = 100\mu s$ , 120pps)	$I_F(pk)$	3	A
Reverse Voltage	$V_R$	5	V
Total Power Dissipation @ $T_A = 25^\circ C$	$P_D$	200	mW
Derate above $25^\circ C$		2.0	$mW/^\circ C$
<b>DETECTOR</b>	$I_C$	100	mA
Collector Current-Continuous			
Emitter-Collector Voltage	$V_{ECO}$	7	V
Collector-Emitter Voltage (CNW82/CNW83)	$V_{CEO}$	50	V
Collector-Emitter Voltage (CNW84/CNW85)		80	
Collector-Base Voltage (CNW83)	$V_{CBO}$	70	V
Collector-Base Voltage (CNW85)		120	
Total Power Dissipation @ $T_A = 25^\circ C$	$P_D$	200	mW
Derate above $25^\circ C$		2.0	$mW/^\circ C$
<b>TOTAL DEVICE</b>			
Storage Temperature Range	$T_{stg}$	-55 to 150	°C
Ambient Operating Temperature Range	$T_A$	-40 to 100	°C
Lead Soldering Temperature (1/16" from case, 10 sec. duration)	$T_L$	260	°C

**CNW82, CNW83, CNW84, CNW85**

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
<b>EMITTER</b>						
Input Forward Voltage	( $I_F = 10 \text{ mA}$ )	$V_F$	—	1.20	1.50	V
Reverse Leakage Current	( $V_R = 5.0 \text{ V}$ )	$I_R$	—	—	10	$\mu\text{A}$
<b>DETECTOR</b>	(CNW82/83)					
Collector-Emitter Breakdown Voltage (CNW84/85)	( $I_C = 1.0 \text{ mA}$ )	$BV_{CEO}$	50	100	—	V
Emitter-Collector Breakdown Voltage	( $I_E = 0.1 \text{ mA}$ )	$BV_{ECO}$	7	10	—	V
Collector-Base Breakdown Voltage	(CNW83)	$BV_{CBO}$	70	100	—	V
	(CNW85)		120	140	—	
Collector-Emitter Dark Current	( $T_A = 25^\circ\text{C}$ )	$I_{CEO}$	—	1	50	nA
	( $T_A = 70^\circ\text{C}$ )		—	0.1	10	$\mu\text{A}$
Collector-Base Cut-off Current	(CNW83/85)	$I_{CBO}$	—	—	20	nA
<b>COUPLED</b>						
Collector-Emitter Saturation Voltage	( $I_C = 4 \text{ mA}, I_F = 10 \text{ mA}$ )	$V_{CE(\text{sat})}$	—	0.15	0.4	V
Isolation Voltage	(DC Value) ( $t = 1.0 \text{ min.}$ ) <sup>(1)</sup>	$V_{ISO}$	8.34	—	—	kV
	(RMS Value) ( $t = 1.0 \text{ min.}$ ) <sup>(1)</sup>		5.9	—	—	
Isolation Resistance	( $V_{I-O} = 500 \text{ V}$ )	$R_{ISO}$	1	10	—	TΩ
Isolation Capacitance	( $V_{I-O} = 0, f = 1.0 \text{ MHz}$ )	$C_{ISO}$	—	0.4	1	pF
Current Transfer Ratio	(CNW82/83) ( $I_F = 10 \text{ mA}, V_{CE} = 0.4 \text{ V}$ )	$CTR$	0.4	0.8	—	%
	(CNW84/85) ( $I_F = 10 \text{ mA}, V_{CE} = 5 \text{ V}$ )		0.63	1.5	3.2	
Capacitance	(CNW83/85) ( $V_{CB} = 10 \text{ V}, f = 1 \text{ MHz}$ )	$C_{CB}$	—	4.5	—	pF
Turn-on Time	( $I_C = 2 \text{ mA}, V_{CC} = 5 \text{ V}, R_L = 100 \Omega$ )	$T_{ON}$	—	3	—	μs
	( $I_C = 2 \text{ mA}, V_{CC} = 5 \text{ V}, R_L = 1 \text{ k}\Omega$ )		—	12	—	
Turn-off Time	( $I_C = 2 \text{ mA}, V_{CC} = 5 \text{ V}, R_L = 100 \Omega$ )	$T_{OFF}$	—	3	—	μs
	( $I_C = 2 \text{ mA}, V_{CC} = 5 \text{ V}, R_L = 1 \text{ k}\Omega$ )		—	12	—	

**NOTE:**

1. Every product is tested with pins 1, 2 and 3 shorted together, and pins 4, 5 and 6 shorted together.

**CNW82, CNW83, CNW84, CNW85**

Fig. 1 Forward Current vs. Forward Voltage

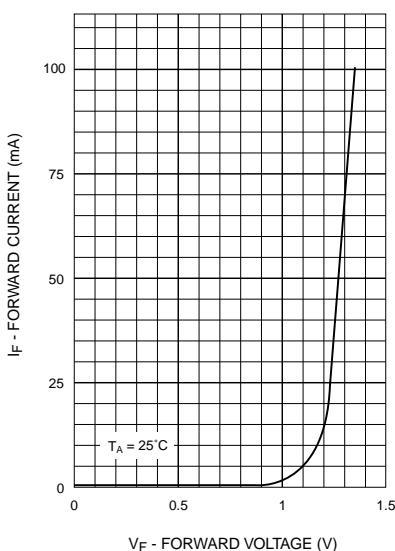


Fig. 3 Collector Current vs. Forward Current  
(for CNW82 and CNW83)

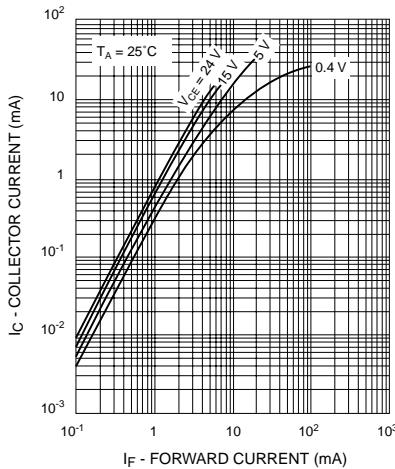


Fig. 5 Collector Current vs. Ambient Temperature  
(for CNW82 and CNW83)

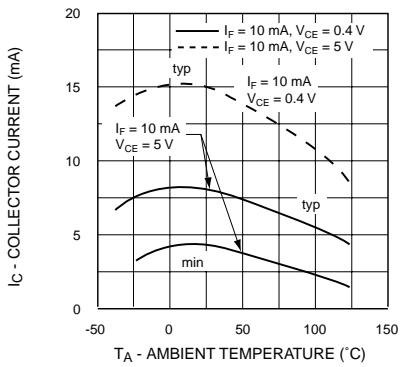


Fig. 2 Collector Current vs. Forward Current  
(for CNW84 and CNW85)

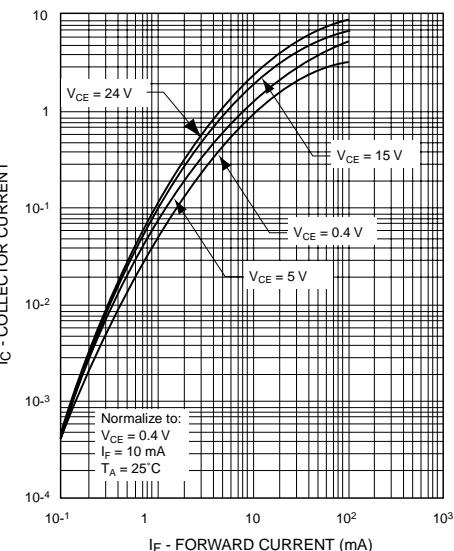


Fig. 4 Collector Current vs. Collector-Emitter Voltage

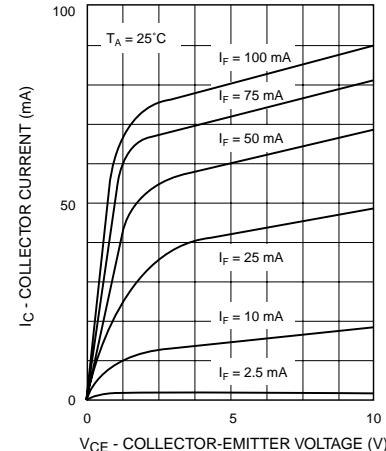
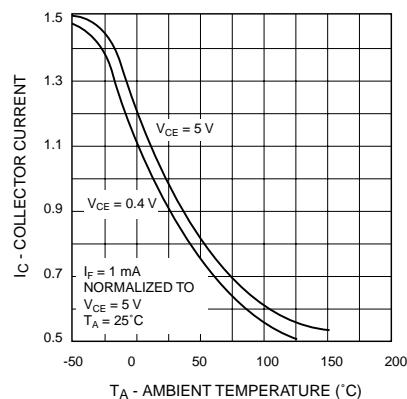
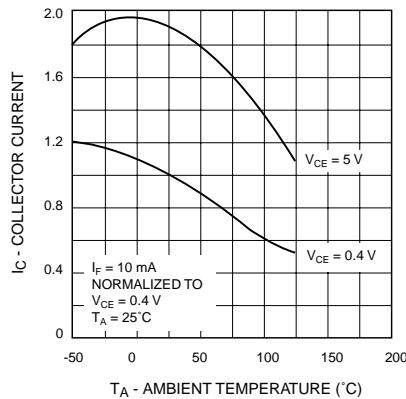


Fig. 6 Collector Current vs. Ambient Temperature  
(for CNW84 and CNW85)

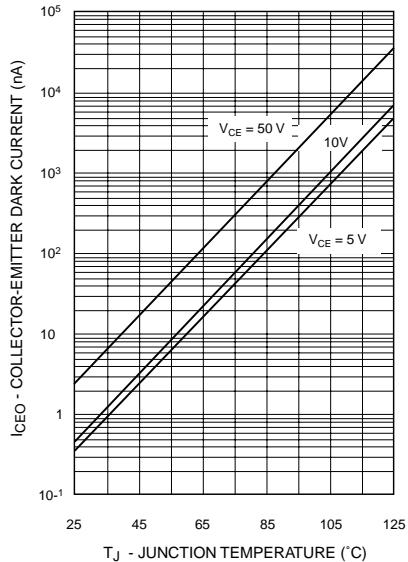


**CNW82, CNW83, CNW84, CNW85**

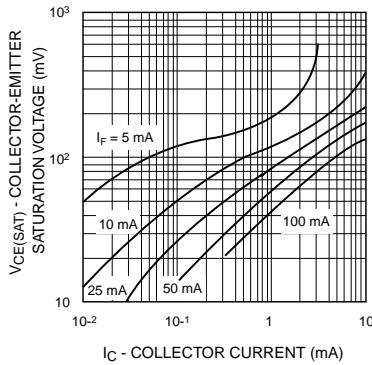
**Fig. 7 Collector Current vs. Ambient Temperature  
(for CNW84 and CNW85)**



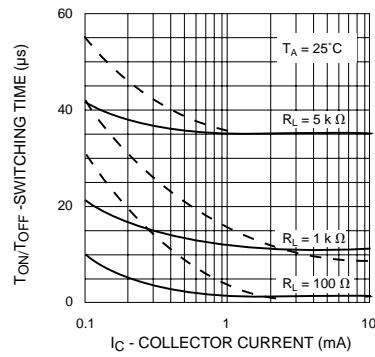
**Fig. 8 Collector-Emitter Dark Current  
vs. Junction Temperature**



**Fig. 9 Collector-Emitter Saturation Voltage  
vs. Collector Current**

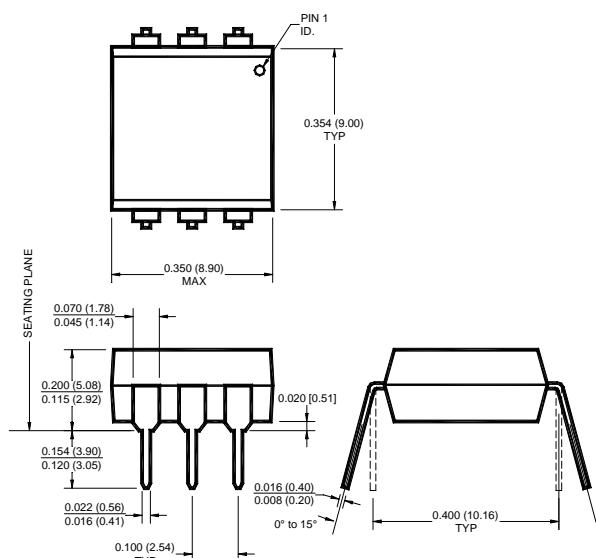


**Fig. 10 Rise and Fall Time vs. Collector Current**

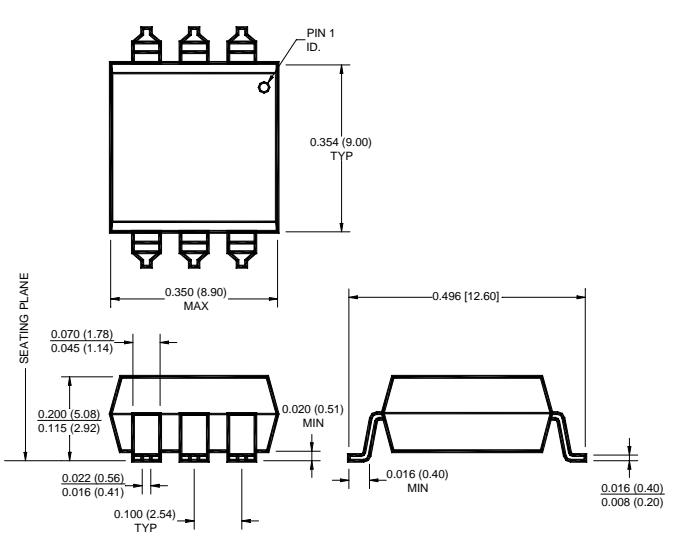


**CNW82, CNW83, CNW84, CNW85**

Package Dimensions (Through Hole)



Package Dimensions (Surface Mount)



**NOTE**

All dimensions are in inches (millimeters)

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